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Preliminary data

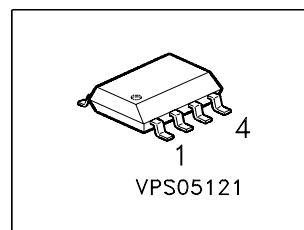
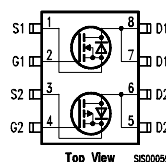
BSO 215 C
SIPMOS[®] Small-Signal-Transistor
Features

- Dual N- and P -Channel
- Enhancement mode
- Logic Level
- Avalanche rated
- dv/dt rated

Product Summary

		N	P	
Drain source voltage	V_{DS}	20	-20	V
Drain-Source on-state resistance	$R_{DS(on)}$	0.1	0.1	Ω
Continuous drain current	I_D	3.7	-3.7	A

Type	Package	Ordering Code
BSO 215 C	SO 8	Q67041-S4025


Maximum Ratings, at $T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Value		Unit
		N	P	
Continuous drain current $T_A = 25\text{ °C}$ $T_A = 70\text{ °C}$	I_D	3.7 3	-3.7 -3	A
Pulsed drain current $T_A = 25\text{ °C}$	$I_D \text{ puls}$	14.8	-14.8	
Avalanche energy, single pulse $I_D = 3\text{ A}$, $V_{DD} = 15\text{ V}$, $R_{GS} = 25\ \Omega$ $I_D = -3.7\text{ A}$, $V_{DD} = -15\text{ V}$, $R_{GS} = 25\ \Omega$	E_{AS}	26 -	- 68	mJ
Avalanche energy, periodic limited by T_{jmax}	E_{AR}	0.2	0.2	
Reverse diode dv/dt, $T_{jmax} = 150\text{ °C}$ $I_S = 3\text{ A}$, $V_{DS} = 16\text{ V}$, $di/dt = 200\text{ A}/\mu\text{s}$ $I_S = -2.7\text{ A}$, $V_{DS} = -16\text{ V}$, $di/dt = -200\text{ A}/\mu\text{s}$	dv/dt	6 -	- 6	kV/ μs
Gate source voltage	V_{GS}	± 20	± 20	V
Power dissipation $T_A = 25\text{ °C}$	P_{tot}	2	2	W
Operating and storage temperature	T_j, T_{stg}	-55...+150		$^{\circ}\text{C}$
IEC climatic category; DIN IEC 68-1		55/150/56		



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Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Thermal resistance, junction - soldering point	N	R_{thJS}	-	-	40	K/W
	P		-	-	40	
SMD version, device on PCB: @ min. footprint; $t \leq 10$ sec. @ 6 cm ² cooling area ¹⁾ ; $t \leq 10$ sec. @ min. footprint; $t \leq 10$ sec. @ 6 cm ² cooling area ¹⁾ ; $t \leq 10$ sec.	N	R_{thJA}	-	-	110	
	N		-	-	62.5	
	P		-	-	100	
	P		-	-	62.5	

Static Characteristics, at $T_j = 25$ °C, unless otherwise specified

Drain- source breakdown voltage $V_{GS} = 0$ V, $I_D = 250$ μ A $V_{GS} = 0$ V, $I_D = -250$ μ A	N	$V_{(BR)DSS}$	20	-	-	V
	P		-20	-	-	
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 10$ μ A $I_D = -450$ μ A	N	$V_{GS(th)}$	1.2	1.5	2	
	P		-1	-1.5	-2	
Zero gate voltage drain current $V_{DS} = 20$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = 20$ V, $V_{GS} = 0$ V, $T_j = 125$ °C $V_{DS} = -20$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = -20$ V, $V_{GS} = 0$ V, $T_j = 125$ °C	N	I_{DSS}	-	0.1	1	μ A
	N		-	10	100	
	P		-	-0.1	-1	
	P		-	-10	-100	
Gate-source leakage current $V_{GS} = 20$ V, $V_{DS} = 0$ V $V_{GS} = -20$ V, $V_{DS} = 0$ V	N	I_{GSS}	-	10	100	nA
	P		-	-10	-100	
Drain-Source on-state resistance $V_{GS} = 4.5$ V, $I_D = 3$ A $V_{GS} = -4.5$ V, $I_D = -3$ A	N	$R_{DS(on)}$	-	0.1	0.15	Ω
	P		-	0.1	0.15	
Drain-Source on-state resistance $V_{GS} = 10$ V, $I_D = 3.7$ A $V_{GS} = -10$ V, $I_D = -3.7$ A	N	$R_{DS(on)}$	-	0.05	0.1	Ω
	P		-	0.06	0.1	

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical without blown air.



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Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Transconductance					S
$V_{DS} \geq 2 * I_D * R_{DS(on)max}, I_D = 3\text{ A}$	N	g_{fs}	2.1	4.4	-
$V_{V_{DS} \geq 2 * I_D * R_{DS(on)max}, I_D = -3\text{ A}}$	P		2.6	5.2	-
Input capacitance					pF
$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N	C_{iss}	-	197	246
$V_{GS} = 0\text{ V}, V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P		-	380	475
Output capacitance					
$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N	C_{oss}	-	109	136
$V_{GS} = 0\text{ V}, V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P		-	290	360
Reverse transfer capacitance					
$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N	C_{rss}	-	59	74
$V_{GS} = 0\text{ V}, V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P		-	103	128
Turn-on delay time					ns
$V_{DD} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 3\text{ A}, R_G = 33\text{ }\Omega$	N	$t_{d(on)}$	-	15	22.5
$V_{DD} = -10, V_{GS} = -4.5\text{ V}, I_D = -3\text{ A}, R_G = 13\text{ }\Omega$	P		-	24	36
Rise time					
$V_{DD} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 3\text{ A}, R_G = 33\text{ }\Omega$	N	t_r	-	88	132
$V_{DD} = -10, V_{GS} = -4.5\text{ V}, I_D = -3\text{ A}, R_G = 13\text{ }\Omega$	P		-	236	354
Turn-off delay time					
$V_{DD} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 3\text{ A}, R_G = 33\text{ }\Omega$	N	$t_{d(off)}$	-	12.3	18.5
$V_{DD} = -10, V_{GS} = -4.5\text{ V}, I_D = -3\text{ A}, R_G = 13\text{ }\Omega$	P		-	87	130
Fall time					
$V_{DD} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 3\text{ A}, R_G = 33\text{ }\Omega$	N	t_f	-	17.1	25.7
$V_{DD} = -10\text{ V}, V_{GS} = -4.5\text{ V}, I_D = -3\text{ A}, R_G = 13\text{ }\Omega$	P		-	168	252



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Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Values			Unit	
		min.	typ.	max.		
Characteristics						
Gate to source charge		Q_{gs}				nC
$V_{DD} = 16$, $I_D = 3.7$ A	N		-	1.3	2	
$V_{DD} = -16$, $I_D = -3.7$ A	P		-	1.9	2.9	
Gate to drain charge		Q_{gd}				
$V_{DD} = 16$, $I_D = 3.7$ A	N		-	3	4.5	
$V_{DD} = -16$, $I_D = -3.7$ A	P		-	4.4	6.6	
Gate charge total		Q_g				
$V_{DD} = 16$, $I_D = 3.7$ A, $V_{GS} = 0$ to 10V	N		-	7.7	11.5	
$V_{DD} = -16$, $I_D = -3.7$ A, $V_{GS} = 0$ to -10V	P		-	13.2	19.8	
Gate plateau voltage		$V_{(plateau)}$				V
$V_{DD} = 16$, $I_D = 3.7$ A	N		-	3.5	-	
$V_{DD} = -16$, $I_D = -3.7$ A	P		-	2.8	-	
Reverse Diode						
Inverse diode continuous forward current		I_S				A
$T_A = 25\text{ °C}$	N		-	-	3.7	
	P		-	-	-3.7	
Inverse diode direct current,pulsed		I_{SM}				
$T_A = 25\text{ °C}$	N		-	-	14.8	
	P		-	-	-14.8	
Inverse diode forward voltage		V_{SD}				V
$V_{GS} = 0$ V, $I_F = I_S$	N		-	0.84	1.1	
$V_{GS} = 0$ V, $I_F = I_S$	P		-	-0.82	-1	
Reverse recovery time		t_{rr}				ns
$V_R = 10$ V, $I_F = I_S$, $di_F/dt = 100$ A/ μ s	N		-	46.5	70	
$V_R = -10$ V, $I_F = I_S$, $di_F/dt = -100$ A/ μ s	P		-	137	205	
Reverse recovery charge		Q_{rr}				μ C
$V_R = 10$ V, $I_F = I_S$, $di_F/dt = 100$ A/ μ s	N		-	18.4	27.6	
$V_R = -10$ V, $I_F = I_S$, $di_F/dt = -100$ A/ μ s	P		-	80	120	

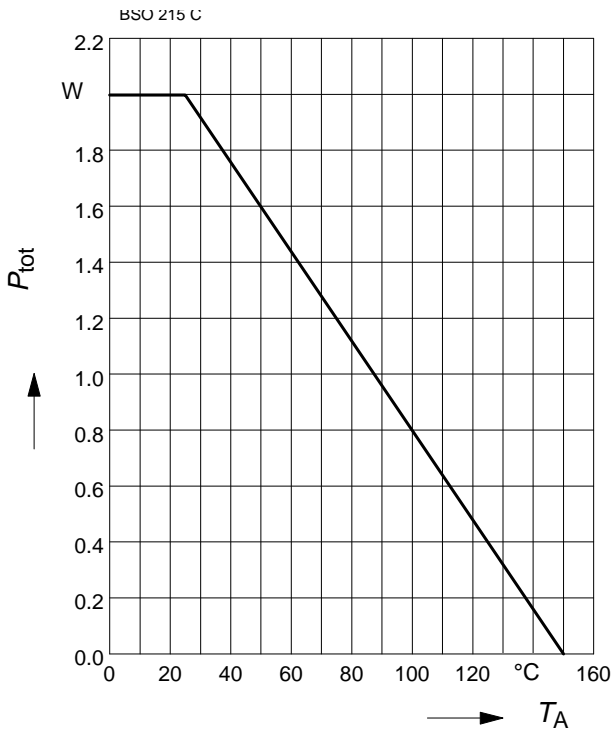


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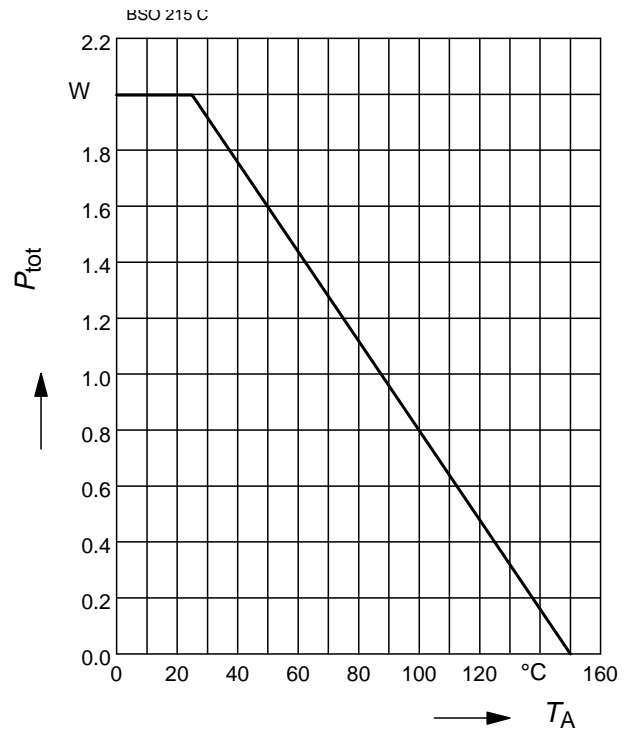
Power Dissipation (N-Ch.)

$$P_{\text{tot}} = f(T_A)$$



Power Dissipation (P-Ch.)

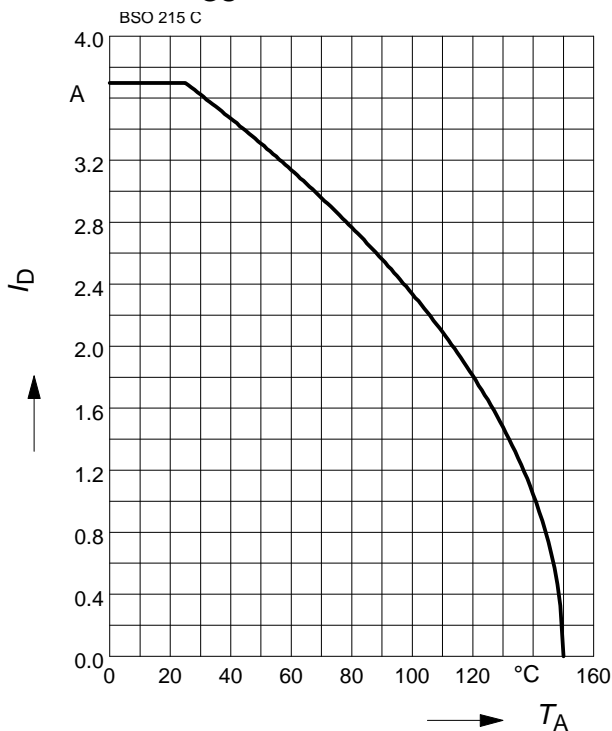
$$P_{\text{tot}} = f(T_A)$$



Drain current (N-Ch.)

$$I_D = f(T_A)$$

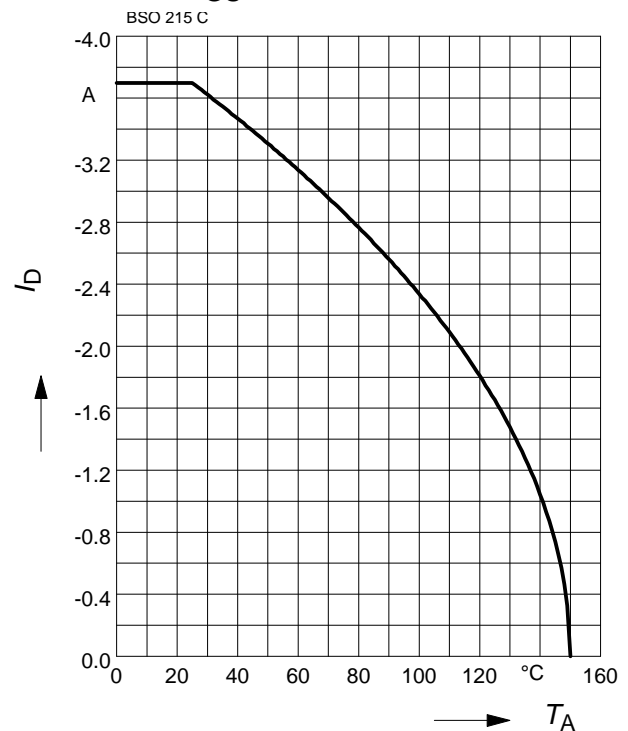
parameter: $V_{GS} \geq 10 \text{ V}$



Drain current (P-Ch.)

$$I_D = f(T_A)$$

parameter: $V_{GS} \geq -10 \text{ V}$





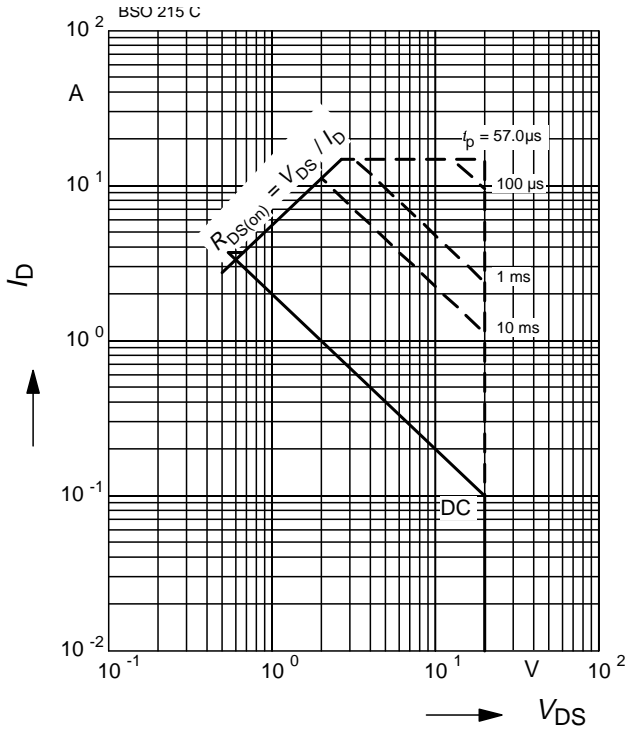
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Safe operating area (N-Ch.)

$I_D = f(V_{DS})$

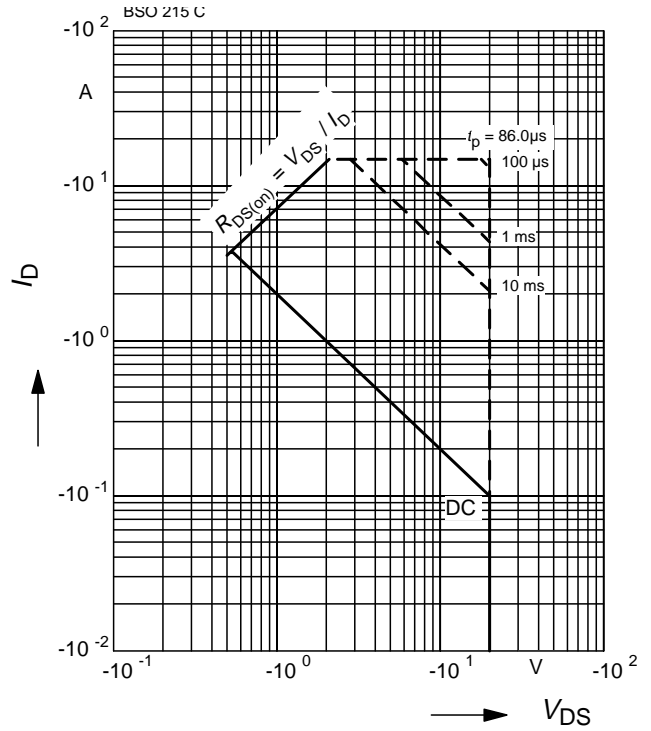
parameter : $D = 0, T_A = 25^\circ\text{C}$



Safe operating area (P-Ch.)

$I_D = f(V_{DS})$

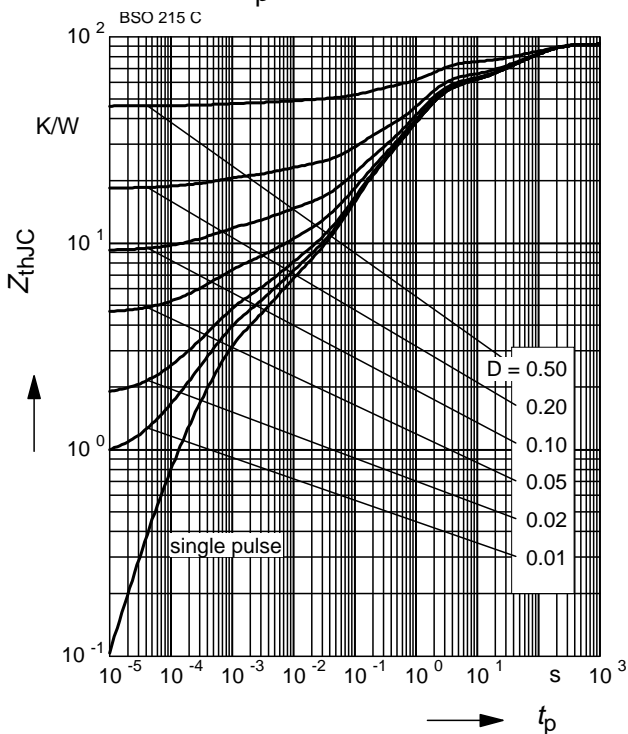
parameter : $D = 0, T_A = 25^\circ\text{C}$



Transient thermal impedance (N-Ch.)

$Z_{thJC} = f(t_p)$

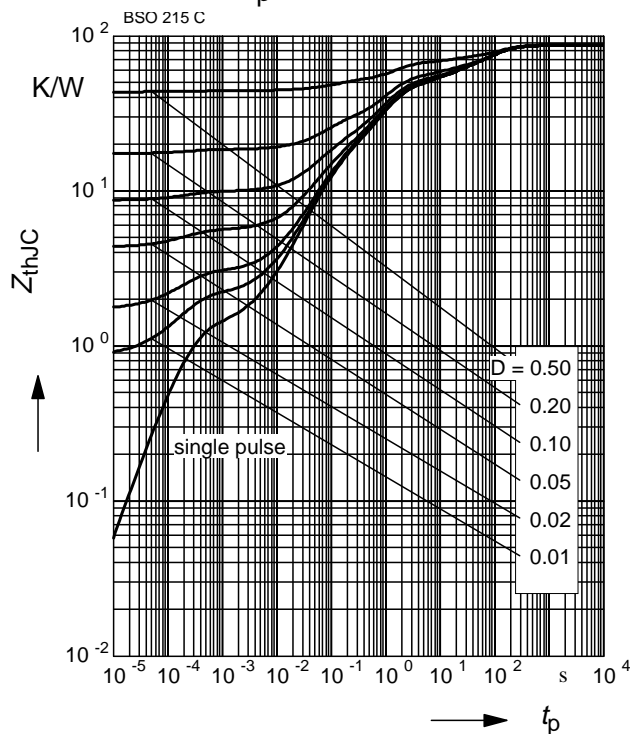
parameter : $D = t_p/T$



Transient thermal impedance (P-Ch.)

$Z_{thJC} = f(t_p)$

parameter : $D = t_p/T$





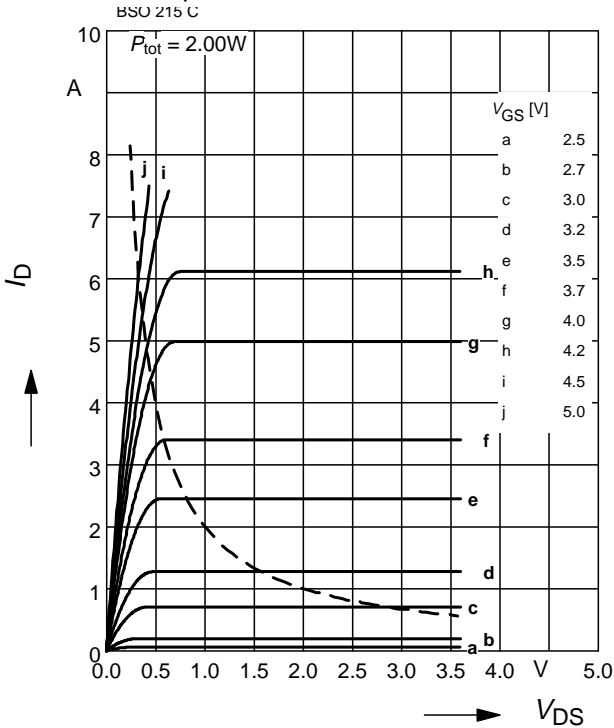
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Typ. output characteristics (N-Ch.)

$I_D = f(V_{DS})$

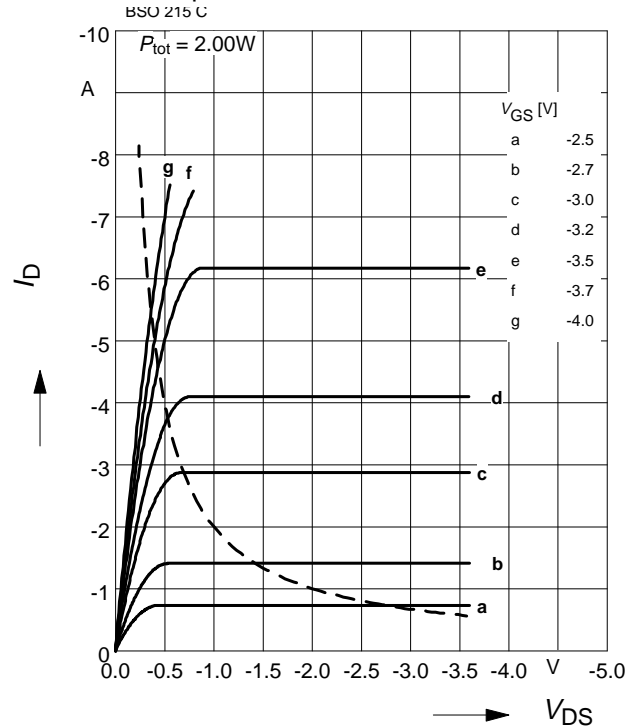
parameter: $t_p = 80 \mu s$



Typ. output characteristics (P-Ch.)

$I_D = f(V_{DS})$

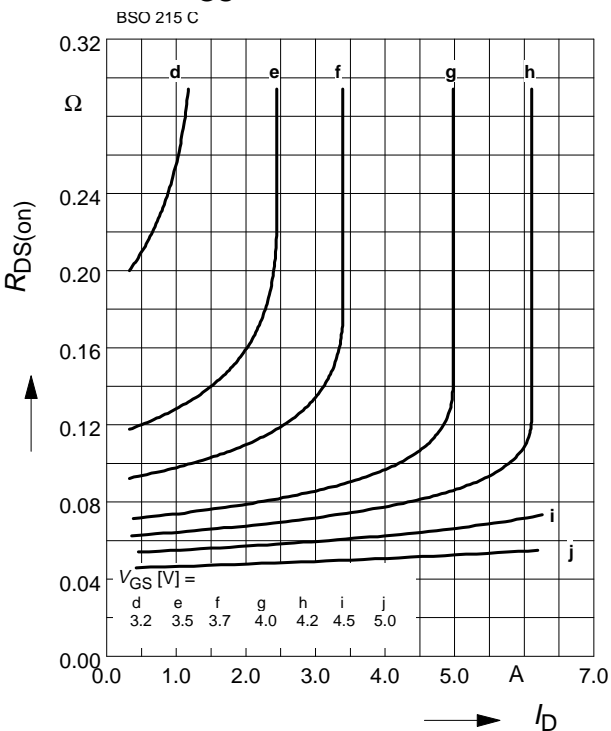
parameter: $t_p = 80 \mu s$



Typ. drain-source-on-resistance (N-Ch.)

$R_{DS(on)} = f(I_D)$

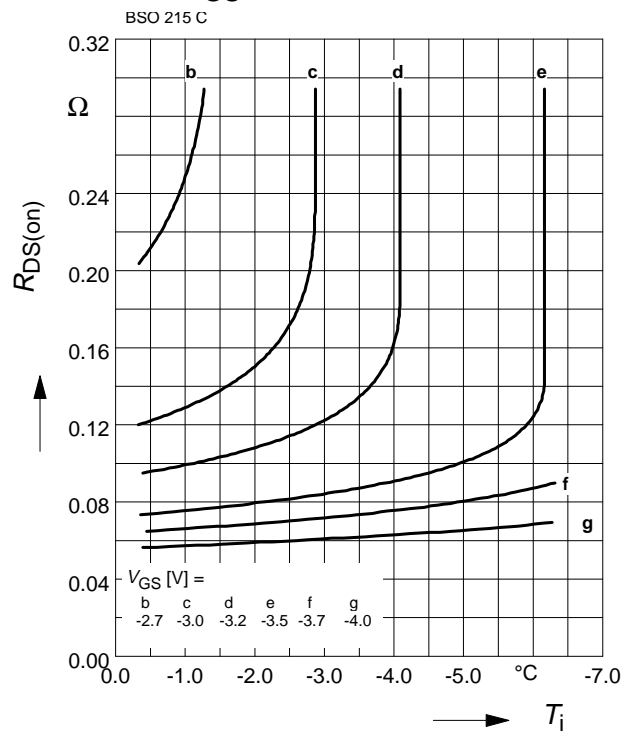
parameter: V_{GS}



Typ. drain-source-on-resistance (P-Ch.)

$R_{DS(on)} = f(I_D)$

parameter: V_{GS}





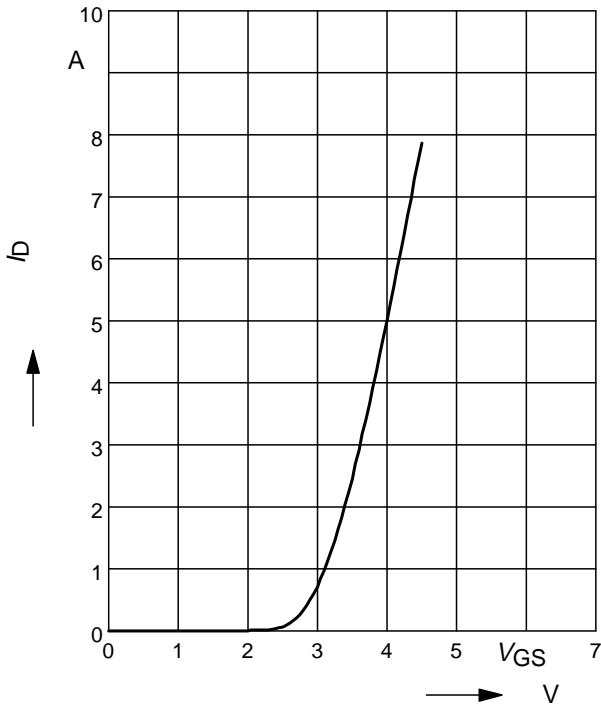
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Typ. transfer characteristics (N-Ch.)

parameter: $t_p = 80 \mu s$

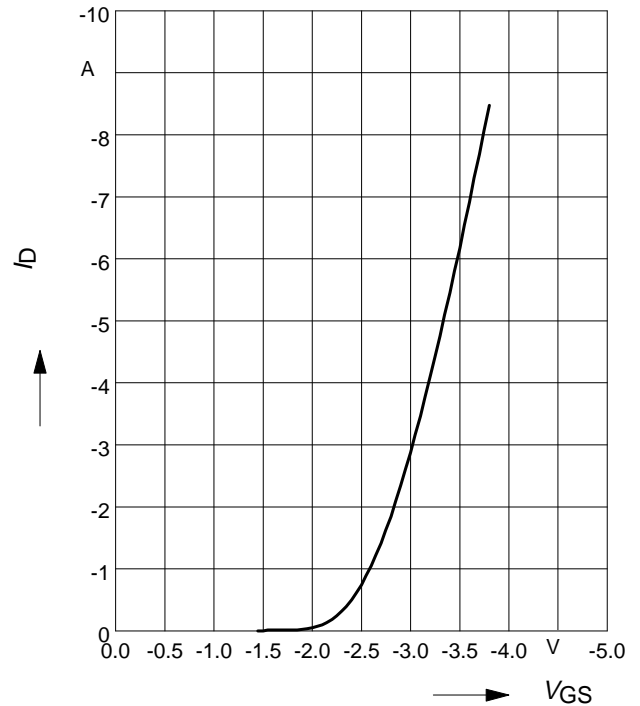
$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



Typ. transfer characteristics (P-Ch.)

parameter: $t_p = 80 \mu s$

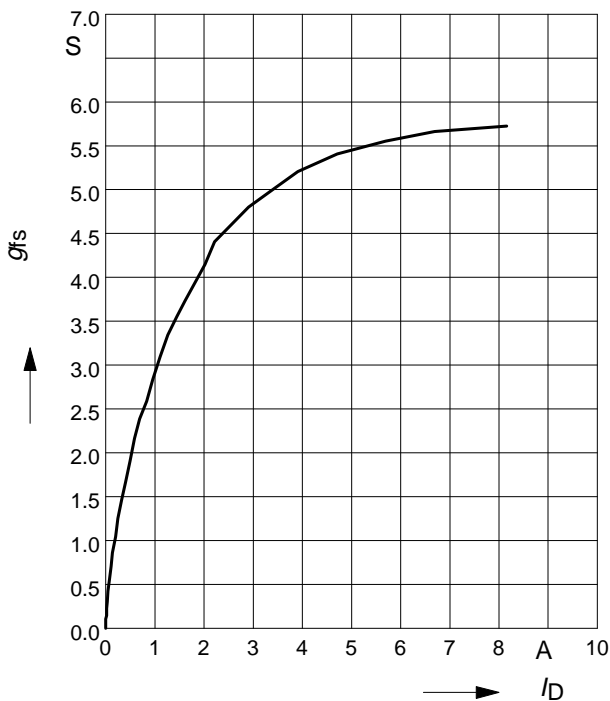
$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



Typ. forward transconductance (N-Ch.)

$g_{fs} = f(I_D); T_j = 25 \text{ }^\circ\text{C}$

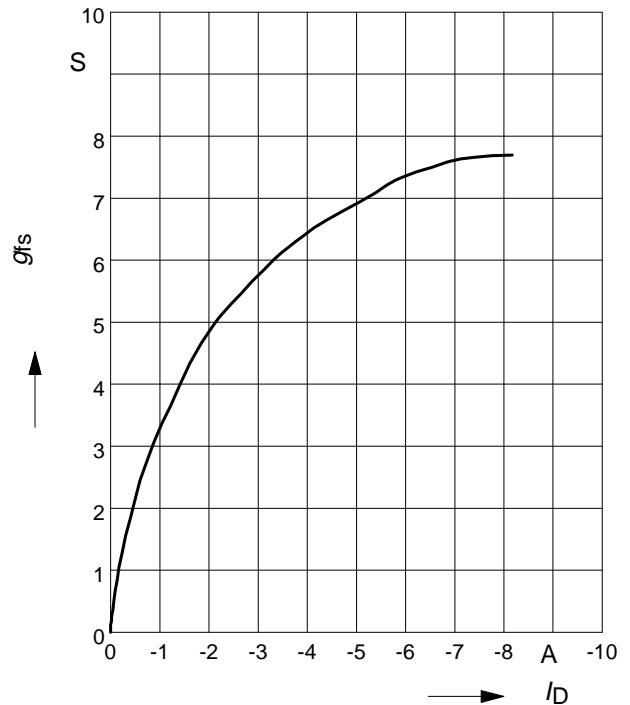
parameter: g_{fs}



Typ. forward transconductance (P-Ch.)

$g_{fs} = f(I_D); T_j = 25 \text{ }^\circ\text{C}$

parameter: g_{fs}





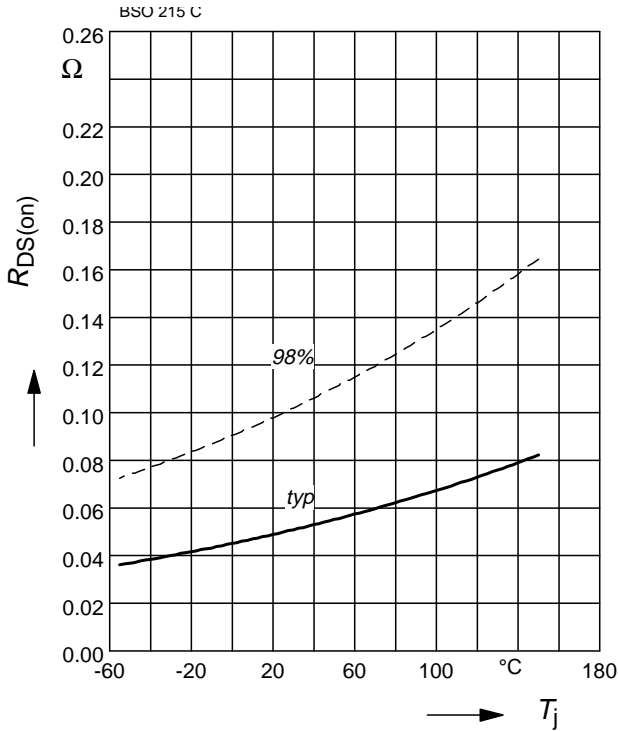
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Drain-source on-resistance (N-Ch.)

$$R_{DS(on)} = f(T_j)$$

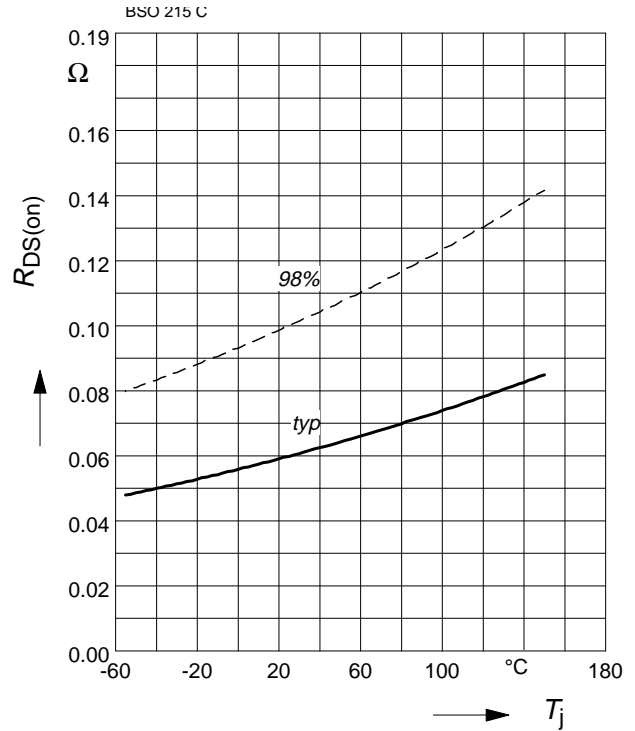
parameter : $I_D = 3.7 \text{ A}$, $V_{GS} = 10 \text{ V}$



Drain-source on-resistance (P-Ch.)

$$R_{DS(on)} = f(T_j)$$

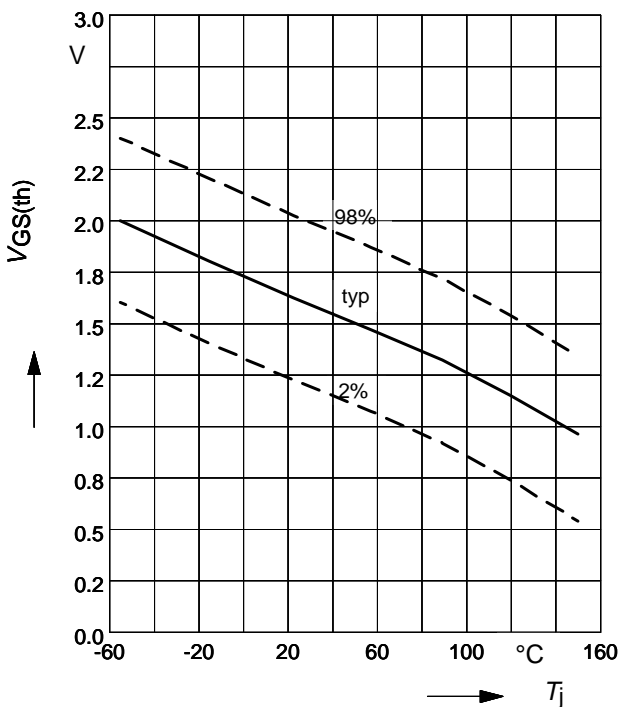
parameter : $I_D = -3.7 \text{ A}$, $V_{GS} = -10 \text{ V}$



Gate threshold voltage (N-Ch.)

$$V_{GS(th)} = f(T_j)$$

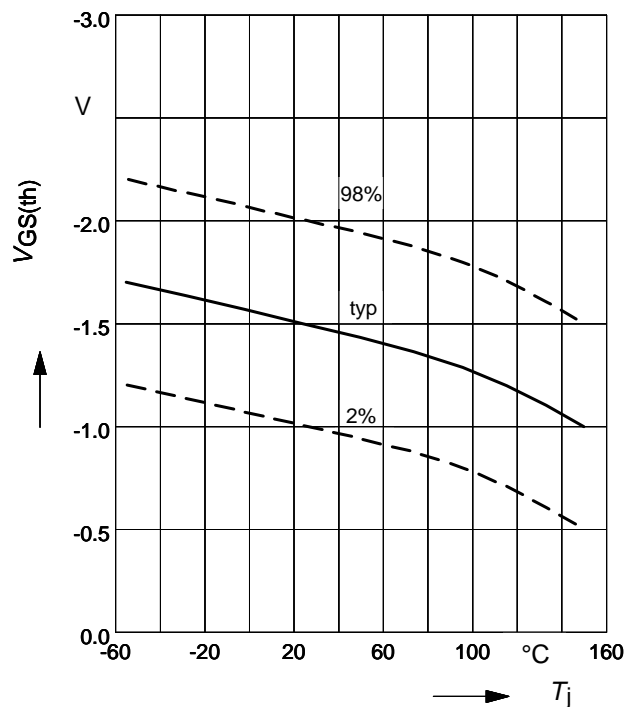
parameter: $V_{GS} = V_{DS}$, $I_D = 10 \mu\text{A}$



Gate threshold voltage (P-Ch.)

$$V_{GS(th)} = f(T_j)$$

parameter: $V_{GS} = V_{DS}$, $I_D = -450 \mu\text{A}$





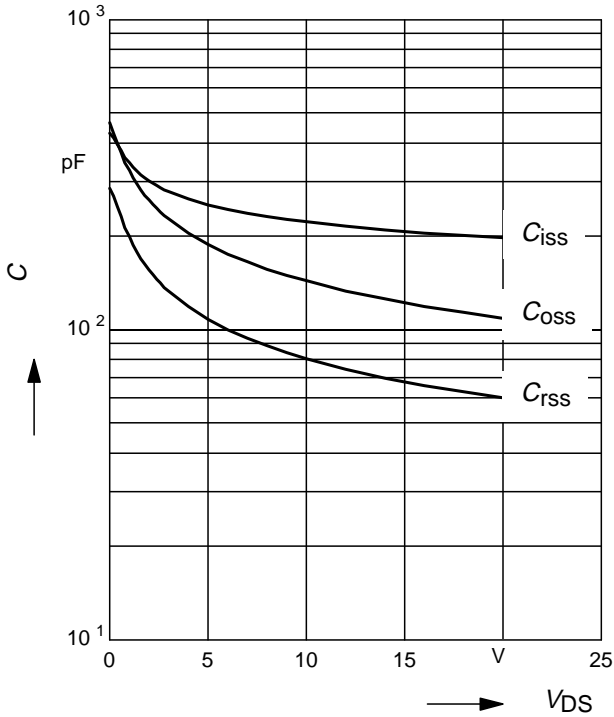
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Typ. capacitances (N-Ch.)

$C = f(V_{DS})$

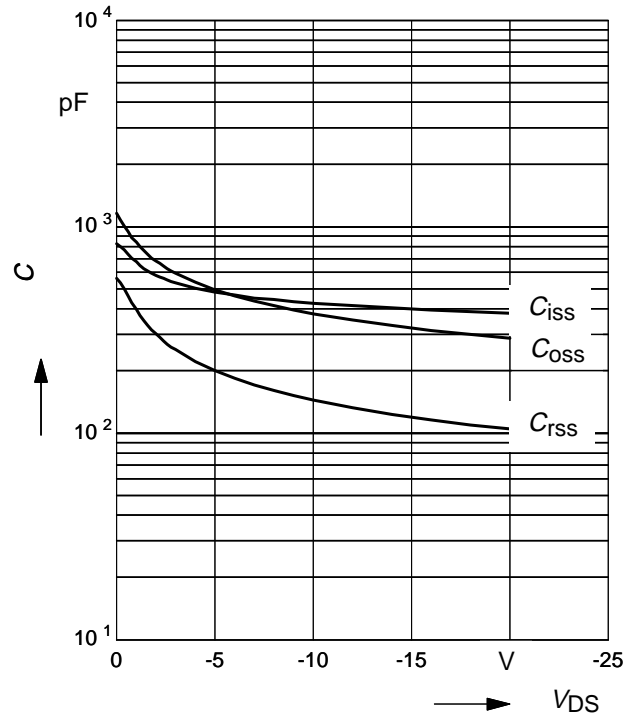
parameter: $V_{GS}=0\text{ V}$, $f=1\text{ MHz}$



Typ. capacitances (P-Ch.)

$C = f(V_{DS})$

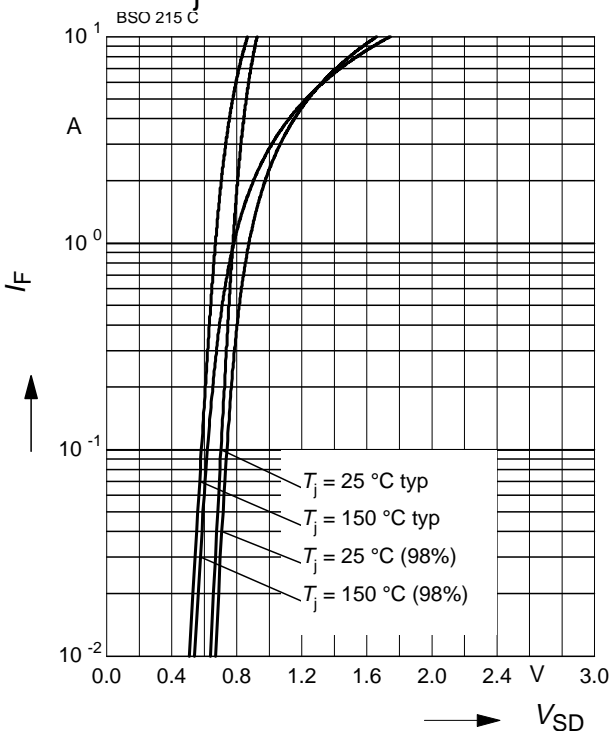
parameter: $V_{GS}=0\text{ V}$, $f=1\text{ MHz}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$, (N-Ch.)

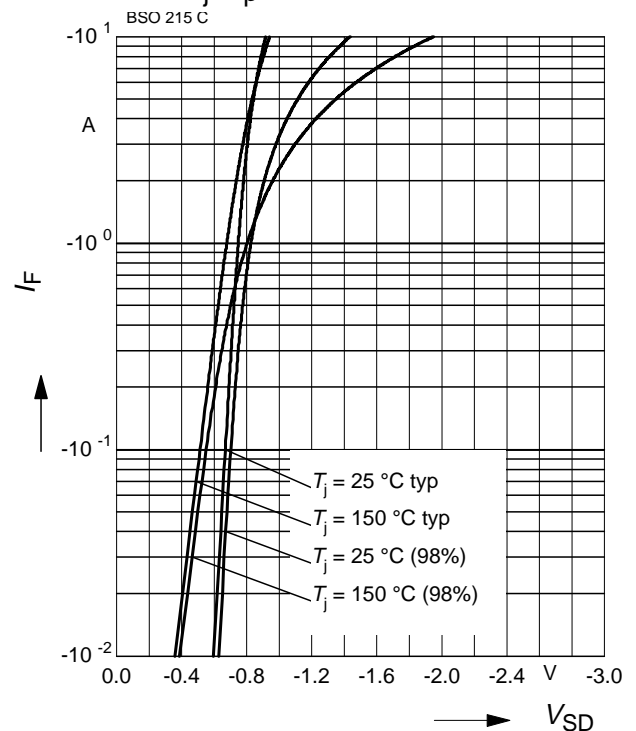
parameter: T_j , $t_p = 80\ \mu\text{s}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$, (P-Ch.)

parameter: T_j , $t_p = 80\ \mu\text{s}$





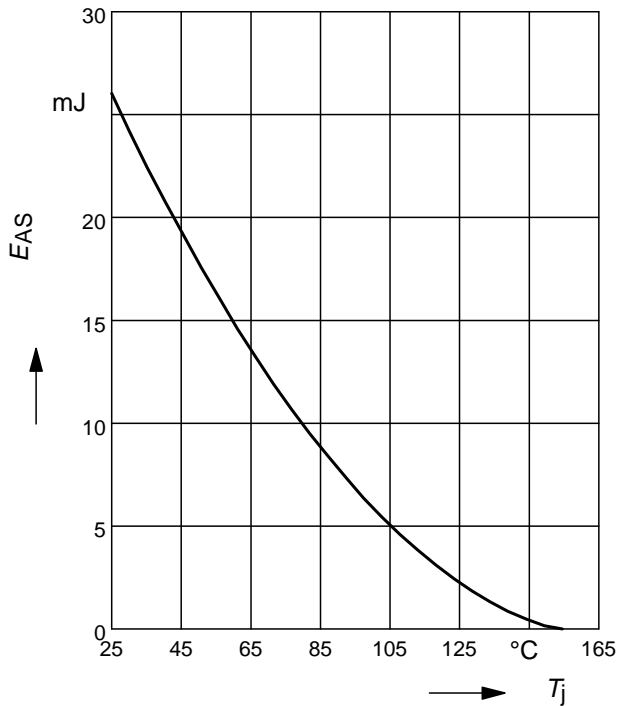
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Avalanche Energy $E_{AS} = f(T_j)$ (N-Ch.)

parameter: $I_D = 3\text{ A}$, $V_{DD} = 15\text{ V}$

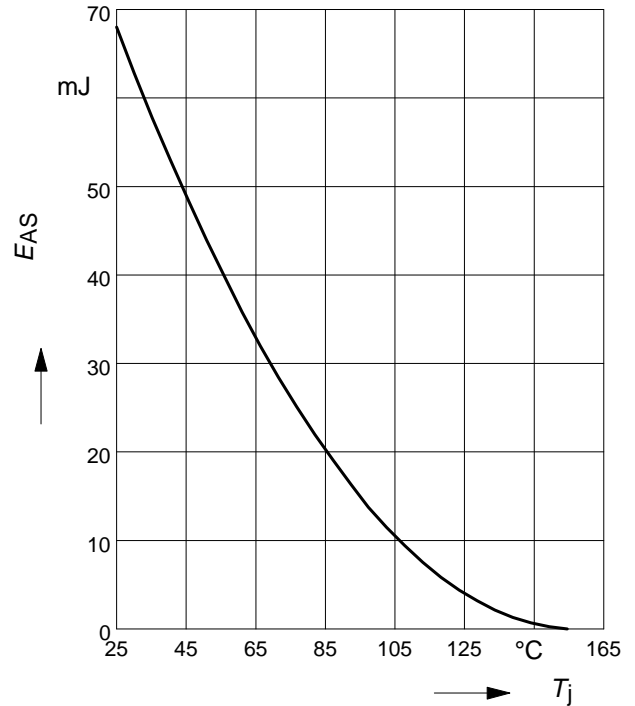
$R_{GS} = 25\ \Omega$



Avalanche Energy $E_{AS} = f(T_j)$

parameter: $I_D = -3.7\text{ A}$, $V_{DD} = -15\text{ V}$

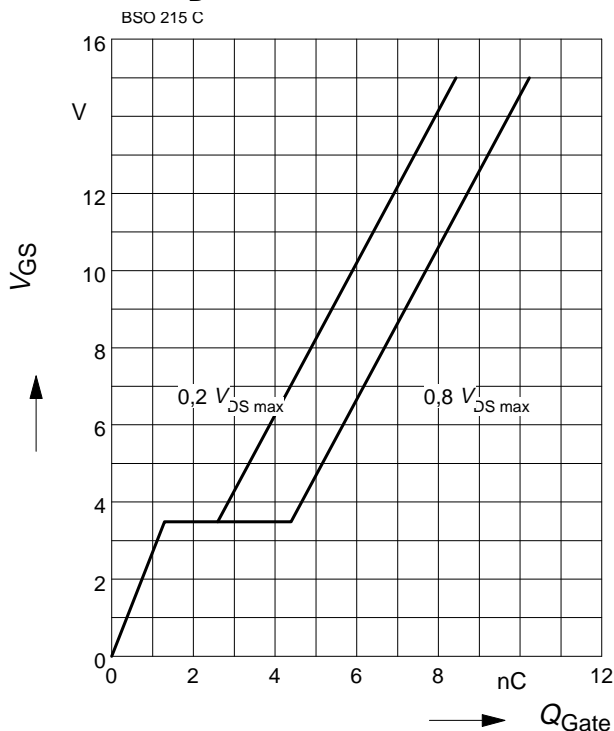
$R_{GS} = 25\ \Omega$



Typ. gate charge (N-Ch.)

$V_{GS} = f(Q_{Gate})$

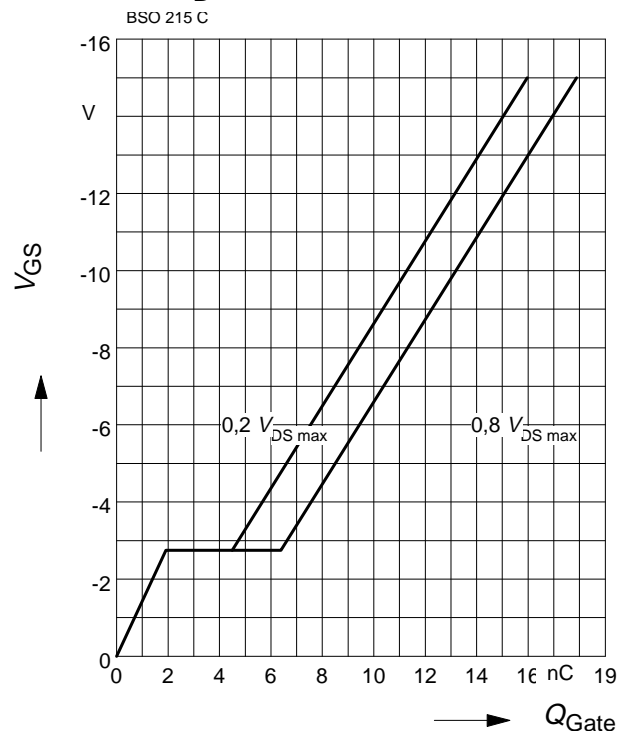
parameter: $I_D = 3.7\text{ A}$



Typ. gate charge (P-Ch.)

$V_{GS} = f(Q_{Gate})$

parameter: $I_D = -3.7\text{ A}$



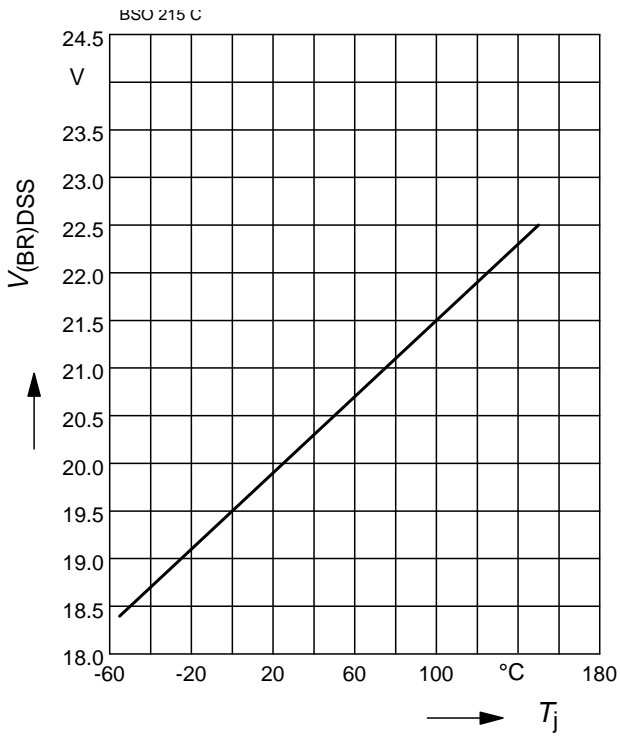


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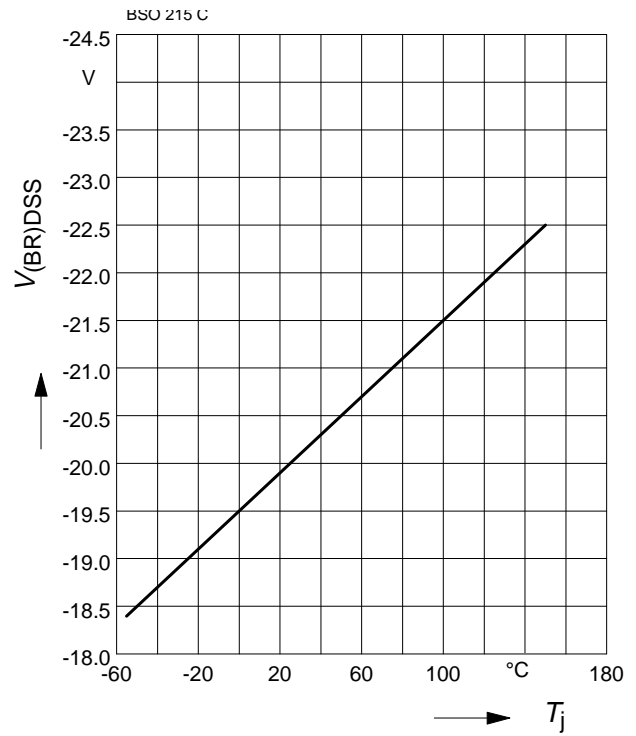
Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), \text{ (N-Ch.)}$$



Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$





Preliminary data

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